

**Population-attributable risk of adverse childhood experiences for high suicide risk, psychiatric admissions, and recurrent depression, in depressed outpatients**

Gloger S, Martínez P, Behn A, Chacón MV, Cottin M, Diez de Medina D, Vöhringer PA.  
European journal of psychotraumatology  
2021; 12(1):1874600

**ARTICLE IDENTIFIERS**

DOI: 10.1080/20008198.2021.1874600

PMID: unavailable

PMCID: not available

**JOURNAL IDENTIFIERS**

LCCN: 2011243919

pISSN: 2000-8198

eISSN: 2000-8066

OCLC ID: 697810686

CONS ID: not available

US National Library of Medicine ID: 101559025

This article was identified from a query of the SafetyLit database.